

### **DESCRIPTION**

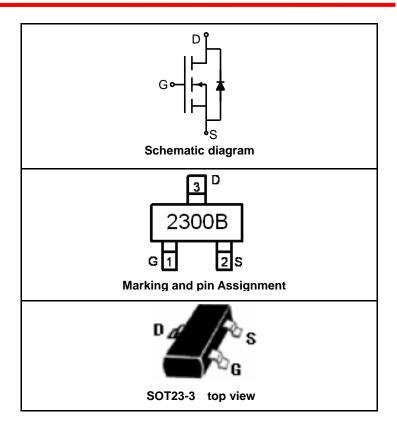
The SSF2300B uses advanced trench technology to provide excellent  $R_{\text{DS(ON)}}$ , low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a Battery protection or in other Switching application.

## **GENERAL FEATURES**

- $V_{DS} = 20V, I_D = 4.5A$   $R_{DS(ON)} < 115mΩ @ V_{GS} = 2.5V$  $R_{DS(ON)} < 60mΩ @ V_{GS} = 4.5V$
- High Power and current handing capability
- Lead free product is acquired
- Surface Mount Package

# **Application**

- Battery protection
- Load switch
- Power management



### PACKAGE MARKING AND ORDERING INFORMATION

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
2300B	SSF2300B	SOT23-3	Ø180mm	8 mm	3000 units

ABSOLUTE MAXIMUM RATINGS(TA=25℃ unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V <sub>DS</sub>	20	V
Gate-Source Voltage	V <sub>GS</sub>	±10	V
Decis Oursell Continuous @ Oursell Dubod (Note 4)	I <sub>D</sub>	4.5	А
Drain Current-Continuous@ Current-Pulsed (Note 1)	I <sub>DM</sub>	16	А
Maximum Power Dissipation	P <sub>D</sub>	1.2	W
Operating Junction and Storage Temperature Range	$T_{J}$ , $T_{STG}$	-55 To 150	$^{\circ}$

### THERMAL CHARACTERISTICS

Thermal Resistance, Junction-to-Ambient (Note 2)	$R_{ heta JA}$	140	°C/W
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**ELECTRICAL CHARACTERISTICS (TA=25** °C unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V I <sub>D</sub> =250μA	20			V



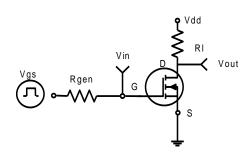
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS}=20V, V_{GS}=0V$			1	μA
Gate-Body Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =±10V,V <sub>DS</sub> =0V			±100	nA
ON CHARACTERISTICS (Note 3)						
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> ,I <sub>D</sub> =250μA	0.65	0.95	1.2	V
Drain-Source On-State Resistance	В	V <sub>GS</sub> =2.5V, I <sub>D</sub> =3.1A		70	115	mΩ
Diam-Source On-State Resistance	$R_{DS(ON)}$	V <sub>GS</sub> =4.5V, I <sub>D</sub> =3.6A		45	60	mΩ
Forward Transconductance	<b>g</b> FS	V <sub>DS</sub> =10V,I <sub>D</sub> =4.5A		8		S
DYNAMIC CHARACTERISTICS (Note4)						
Input Capacitance	C <sub>lss</sub>			500		PF
Output Capacitance	C <sub>oss</sub>	$V_{DS}$ =10V, $V_{GS}$ =0V, F=1.0MHz		250		PF
Reverse Transfer Capacitance	C <sub>rss</sub>			90		PF
SWITCHING CHARACTERISTICS (Note 4)						
Turn-on Delay Time	t <sub>d(on)</sub>			7		nS
Turn-on Rise Time	t <sub>r</sub>	$V_{DD}=10V, R_{L}=2.8 \Omega$		55		nS
Turn-Off Delay Time	t <sub>d(off)</sub>	$V_{GS}$ =4.5 $V$ , $R_{GEN}$ =6 $\Omega$ , $I_{D}$ =3.6 $A$ ,		16		nS
Turn-Off Fall Time	t <sub>f</sub>			10		nS
Total Gate Charge	Qg			10		nC
Gate-Source Charge	Q <sub>gs</sub>	V <sub>DS</sub> =10V,I <sub>D</sub> =4.2A,V <sub>GS</sub> =4.5V		2.3		nC
Gate-Drain Charge	$Q_{gd}$			2.9		nC
DRAIN-SOURCE DIODE CHARACTERISTI	cs	-		ı		
Diode Forward Voltage (Note 3)	V <sub>SD</sub>	V <sub>GS</sub> =0V,I <sub>S</sub> =1.3A			1.2	V
		1	1		1	

# NOTES:

- Repetitive Rating: Pulse width limited by maximum junction temperature.
   Surface Mounted on FR4 Board, t ≤ 10 sec.
   Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 2%.
   Guaranteed by design, not subject to production testing.

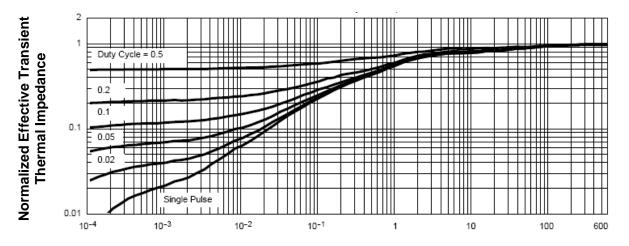


## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



**Figure 1: Switching Test Circuit** 

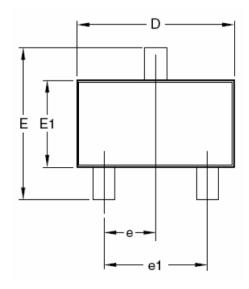
Figure 2:Switching Waveforms

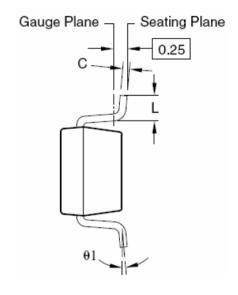


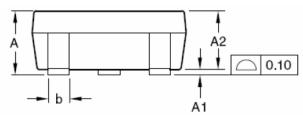
Square Wave Pluse Duration(sec)
Figure 3: Normalized Maximum Transient Thermal Impedance



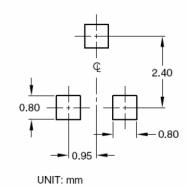
# **SOT23-3 PACKAGE INFORMATION**







### RECOMMENDED LAND PATTERN



# **Dimensions in millimeters**

Symbols	Min. Nom.		Max.		
Α	0.90	_	1.25		
A1	0.00	_	0.13		
A2	0.70	1.00	1.15		
b	0.30	0.40	0.50		
С	0.08	0.13	0.20		
D	2.80	2.90	3.10		
E	2.60	2.80	3.00		
E1	1.40	1.60	1.80		
е	0.95 BSC				
e1	1.90 BSC				
L	0.30	_	0.60		
θ1	0°	5°	8°		

### Dimensions in inches

Symbols	Min.	Nom.	Max.		
Α	0.035		0.049		
A1	0.000	_	0.005		
A2	0.028	0.039	0.045		
b	0.012	0.016	0.020		
С	0.003	0.005	0.008		
D	0.110	0.114	0.122		
E	0.102	0.110	0.118		
E1	0.055	0.063	0.071		
е	0.037 BSC				
e1	0.075 BSC				
L	0.012	_	0.024		
θ1	0°	5°	8°		

# **NOTES:**

- 1. Tolerance ±0.10mm (4 mil) unless otherwise specified
- 2. Package body sizes exclude mold flash and gate burrs. Mold flash at the non-lead sides should be less than 5 mils.
- 3. Dimension L is measured in gauge plane.
- 4. Controlling dimension is millimeter, converted inch dimensions are not necessarily exact.



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